

**Search Notes**

Application/Control No.

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Examiner

Matthew D. Matzek

Applicant(s)/Patent under  
Reexamination

FANG ET AL.

Art Unit

1771

**SEARCHED**

Class	Subclass	Date	Examiner
442	59	4/28/2005	MM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	4/28/2005	MM
Inventor Search	4/29/2005	MM